


<b>Search Notes</b>  	<b>Application/Control No.</b>  10533115	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAYAMA ET AL.
	<b>Examiner</b>  Wang, Chang-Yu	<b>Art Unit</b>  1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, STN: search strategy attached	9/14/07	CYW
Inventor name search: EAST, STN, PALM	9/14/07	CYW
PLUS search from STIC. see search results in eDAN (3/5/07)	9/14/07	CYW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner